

NTTD4401F

FETKY™ Power MOSFET and Schottky Diode

-20 V, -3.3 A P-Channel with 20 V, 1.0 A Schottky Diode, Micro8™ Package

The FETKY product family incorporates low RDS(on), true logic level MOSFETs packaged with industry leading, low forward drop, low leakage Schottky Barrier Diodes to offer high efficiency components in a space saving configuration. Independent pinouts for TMOS and Schottky die allow the flexibility to use a single component for switching and rectification functions in a wide variety of applications.

Features

- Low V_F and Low Leakage Schottky Diode
- Lower Component Placement and Inventory Costs along with Board Space Savings
- Logic Level Gate Drive – Can be Driven by Logic ICs

Applications

- Buck Converter
- Synchronous Rectification
- Low Voltage Motor Control
- Load Management in Battery Packs, Chargers, Cell Phones, and other Portable Products

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Rating		Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	-20	V	
Gate-to-Source Voltage		V _{GS}	-10	V	
Continuous Drain Current (Note 1)	T _A = 25°C	I _D	3.3	A	
	T _A = 100°C		2.1		
Power Dissipation (Note 1)	Steady State	P _D	T _A = 25°C	1.42	W
			T _A = 100°C		
Continuous Drain Current (Note 2)		I _D	T _A = 25°C	2.4	A
			T _A = 100°C		
Power Dissipation (Note 2)	Steady State	P _D	T _A = 25°C	0.78	W
Pulsed Drain Current	t = 10 μs	I _{DM}	10	A	
Operating Junction and Storage Temperature		T _J , T _{STG}	-55 to 150	°C	
Single Pulse Drain-to-Source Avalanche Energy Starting T _A = 25°C (t ≤ 10 s)		EAS	150	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T _L	260	°C	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 inch sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
2. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).



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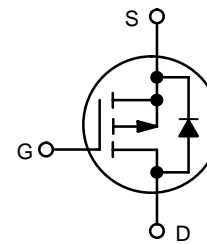
<http://onsemi.com>

MOSFET PRODUCT SUMMARY

V _{(BR)DSS}	R _{DS(on)} TYP	I _D Max
-20 V	70 mΩ @ -4.5 V	-3.3 A
	100 mΩ @ -2.7 V	-2.7 A

SCHOTTKY DIODE SUMMARY

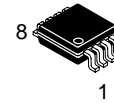
V _R Max	I _F Max	V _F Max
20 V	2.0 A	600 mV @ I _F = 2.0 A



P-Channel MOSFET

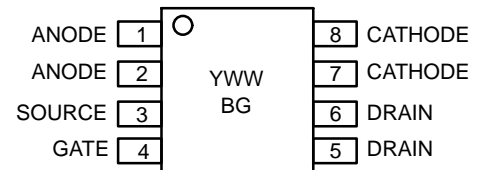


SCHOTTKY DIODE



Micro8
CASE 846A

MARKING DIAGRAM & PIN CONNECTIONS



(Top View)

Y = Year
WW = Work Week
BG = Device Code

ORDERING INFORMATION

Device	Package	Shipping†
NTTD4401FR2	Micro8	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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SCHOTTKY DIODE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V	20	V
Average Forward Current (Rated V_R , $T_A = 100^\circ\text{C}$)	I_O	1.0	A
Peak Repetitive Forward Current (Note 3)	I_{FRM}	2.0	A
Non-Repetitive Peak Surge Current (Note 4)	I_{FSM}	20	A

THERMAL RESISTANCE RATINGS

Rating	Symbol	FET	Schottky	Unit
		Max		
Junction-to-Ambient – Steady State (Note 5)	$R_{\theta JA}$	88	135	$^\circ\text{C/W}$
Junction-to-Ambient – Steady State (Note 6)	$R_{\theta JA}$	160	250	$^\circ\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$	-20	-	-	V
Zero Gate Voltage Drain Current (Note 7)	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = -16\text{ V}$	-	-	-1.0	μA
		$V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C}, V_{DS} = -16\text{ V}$	-	-	-25	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 10\text{ V}$	-	-	± 100	nA

ON CHARACTERISTICS

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\ \mu\text{A}$	-0.5	-	-1.5	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$	-	-	2.5	-	$\text{mV}/^\circ\text{C}$
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = -4.5\text{ V}, I_D = -3.3\text{ A}$	-	70	90	$\text{m}\Omega$
		$V_{GS} = -2.5\text{ V}, I_D = -1.2\text{ A}$	-	100	150	
Forward Transconductance	g_{FS}	$V_{DS} = -10\text{ V}, I_D = -2.7\text{ A}$	-	4.2	-	S

CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}, V_{DS} = -16\text{ V}$	-	550	750	pF
Output Capacitance	C_{OSS}		-	200	300	
Reverse Transfer Capacitance	C_{RSS}		-	50	175	
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -4.5\text{ V}, V_{DS} = -16\text{ V}, I_D = -3.3\text{ A}$	-	10	18	nC
Gate-to-Source Gate Charge	Q_{GS}		-	1.5	3.0	
Gate-to-Drain "Miller" Charge	Q_{GD}		-	5.0	10	

SWITCHING CHARACTERISTICS

Turn-On Delay Time	$t_{d(ON)}$	$V_{GS} = -4.5\text{ V}, V_{DD} = -10\text{ V}, I_D = -3.3\text{ A}, R_G = 6.0\ \Omega$	-	11	20	ns
Rise Time	t_r		-	35	65	
Turn-Off Delay Time	$t_{d(OFF)}$		-	33	60	
Fall Time	t_f		-	29	55	

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = -2.0\text{ A}$	-	-0.88	-1.0	V
Reverse Recovery Time	t_{RR}	$V_{GS} = 0\text{ V}, dI_S/dt = 100\text{ A}/\mu\text{s}, I_S = -3.3\text{ A}$	-	37	50	ns
Charge Time	t_a		-	16	-	
Discharge Time	t_b		-	21	-	
Reverse Recovery Charge	Q_{RR}	-	-	0.025	0.05	nC

3. Rated V_R , square wave, 20 kHz, $T_A = 105^\circ\text{C}$.

4. Surge applied at rated load conditions, half-wave, single phase, 60 Hz.

5. Surface-mounted on FR4 board using 1 inch sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

6. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).

7. Body diode leakage current.

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SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit	
Reverse Breakdown Voltage	B_V	$I_R = 1.0 \text{ mA}$	20	-	-	V	
Reverse Leakage Current	I_R	$V_R = 20 \text{ V}$	$T_A = 25^\circ\text{C}$	-	-	0.05	mA
			$T_A = 125^\circ\text{C}$	-	-	10	
Forward Voltage	V_F	$I_F = 1.0 \text{ A}$	$T_A = 25^\circ\text{C}$	-	-	0.5	V
			$T_A = 125^\circ\text{C}$	-	-	0.39	
		$I_F = 2.0 \text{ A}$	$T_A = 25^\circ\text{C}$	-	-	0.6	
			$T_A = 125^\circ\text{C}$	-	-	0.53	
Voltage Rate of Change	dV/dt	$V_R = 20 \text{ V}$	-	10,000	-	V/ μs	

TYPICAL ELECTRICAL CHARACTERISTICS

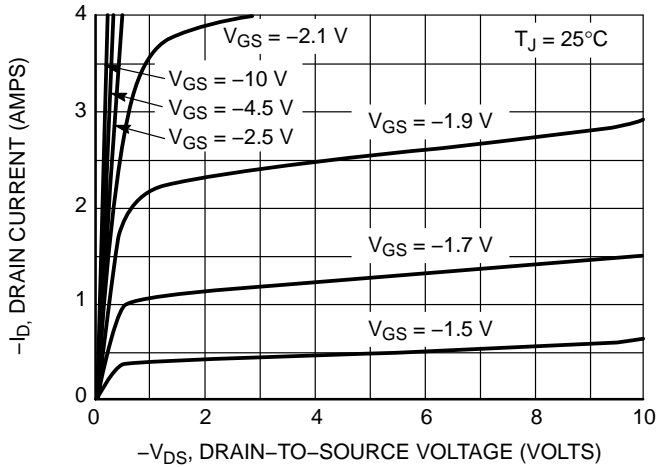


Figure 1. On-Region Characteristics

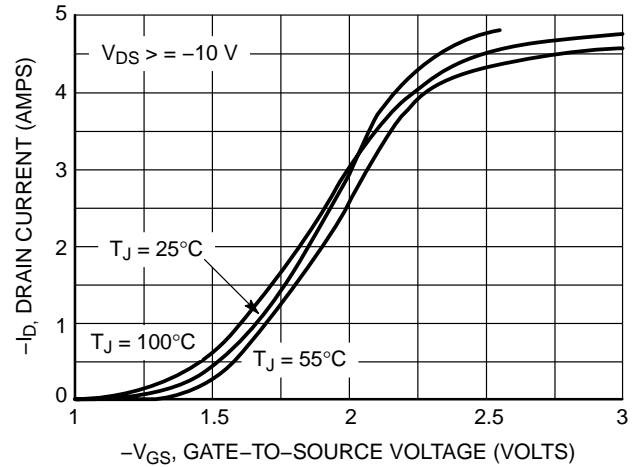


Figure 2. Transfer Characteristics

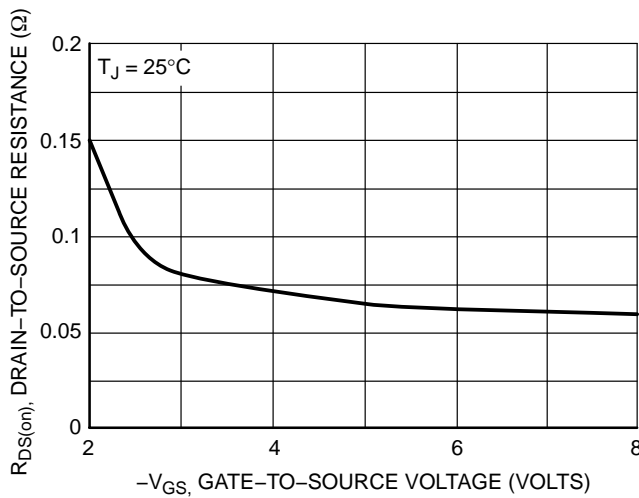


Figure 3. On-Resistance vs. Gate-to-Source Voltage

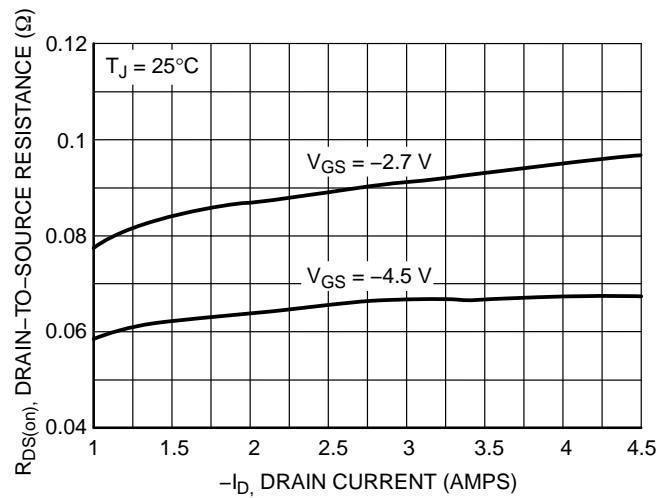


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

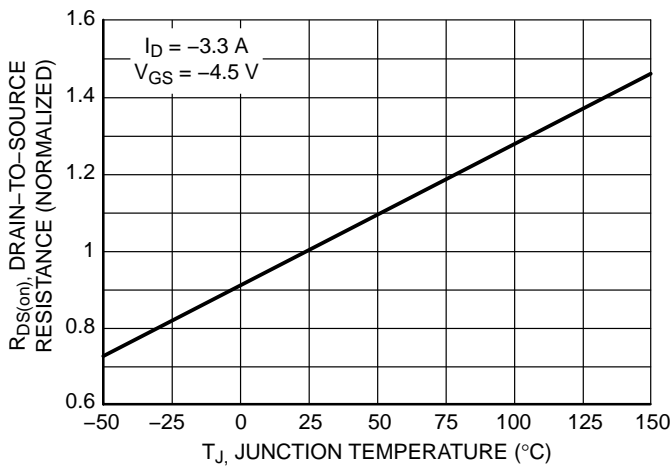


Figure 5. On-Resistance Variation with Temperature

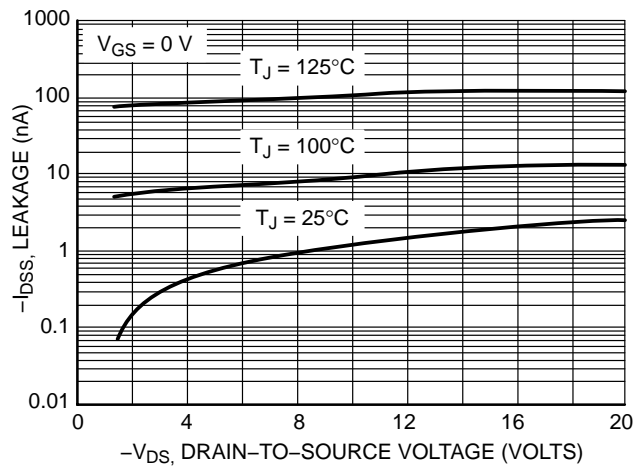


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL ELECTRICAL CHARACTERISTICS

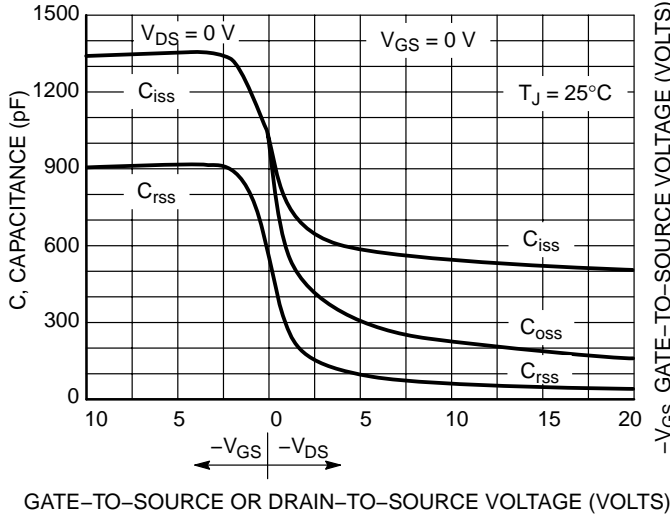


Figure 7. Capacitance Variation

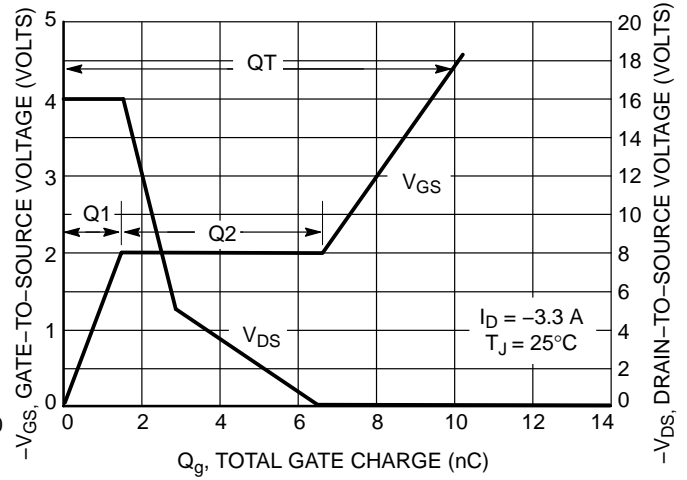


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

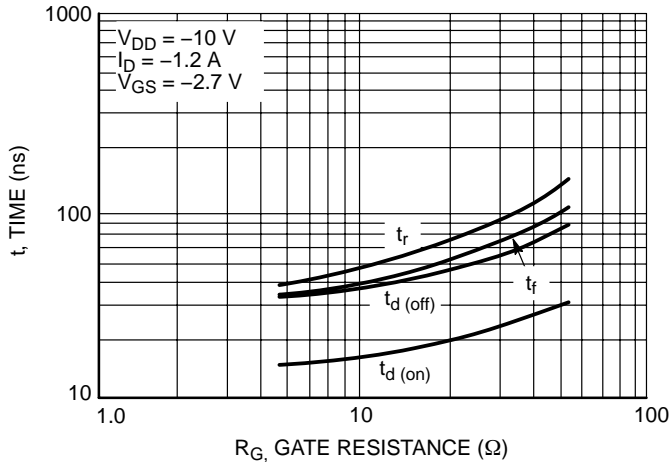


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

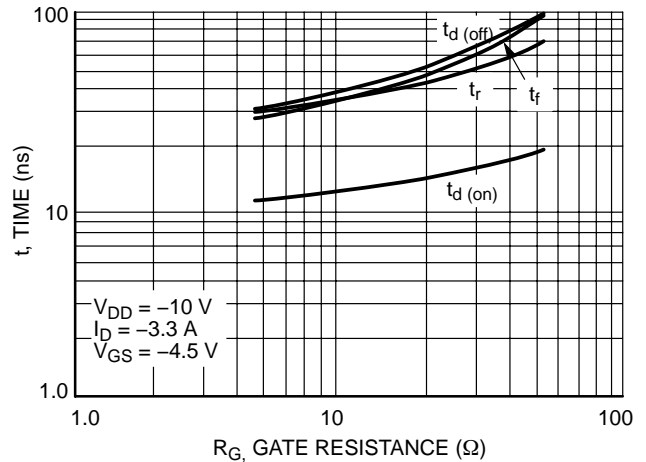


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

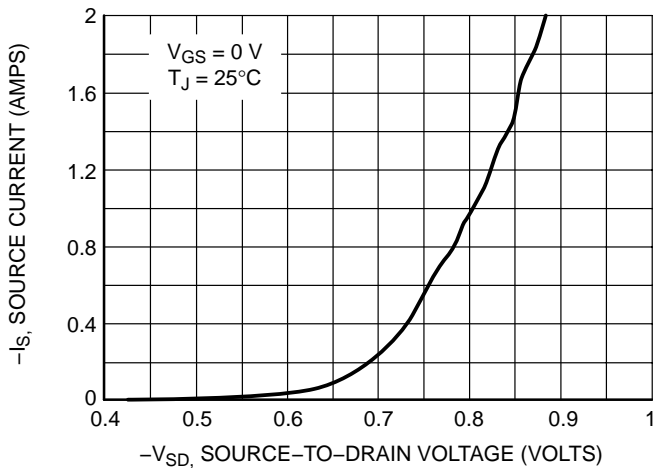


Figure 11. Diode Forward Voltage vs. Current

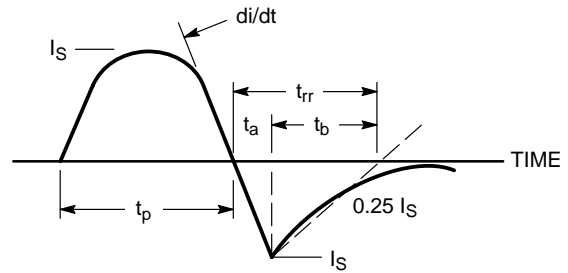


Figure 12. Diode Reverse Recovery Waveform

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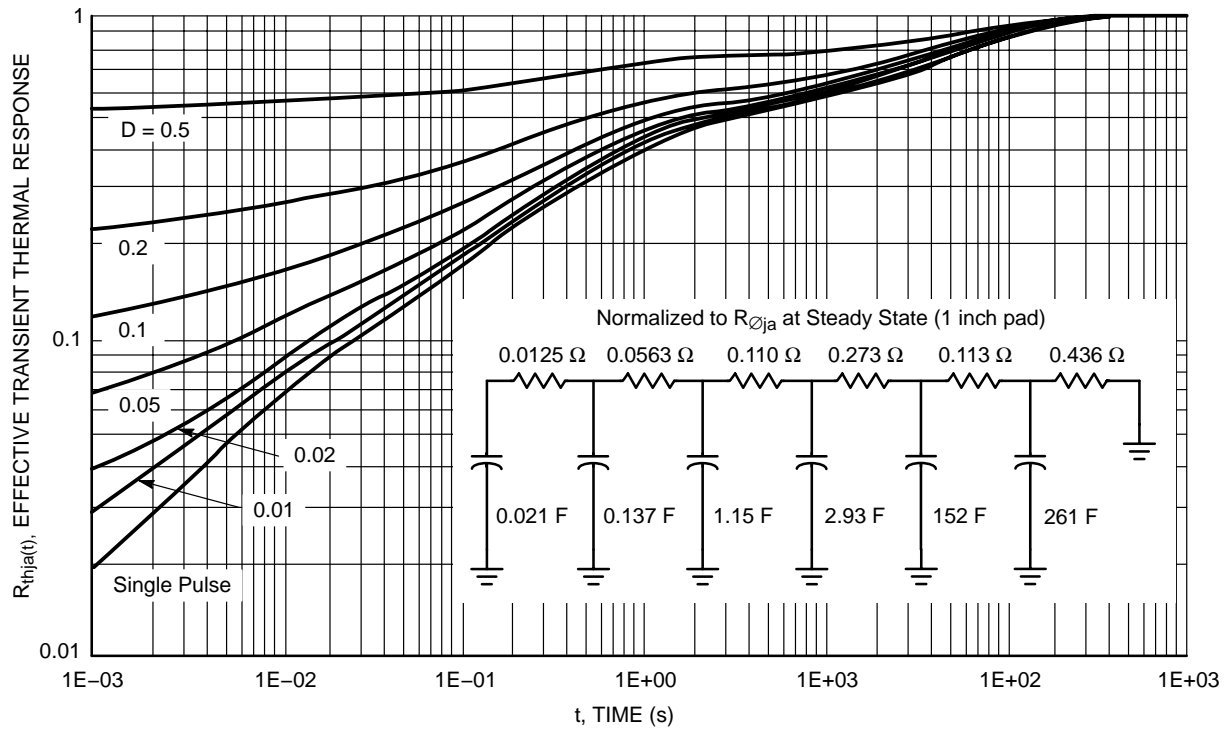


Figure 13. FET Thermal Response

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

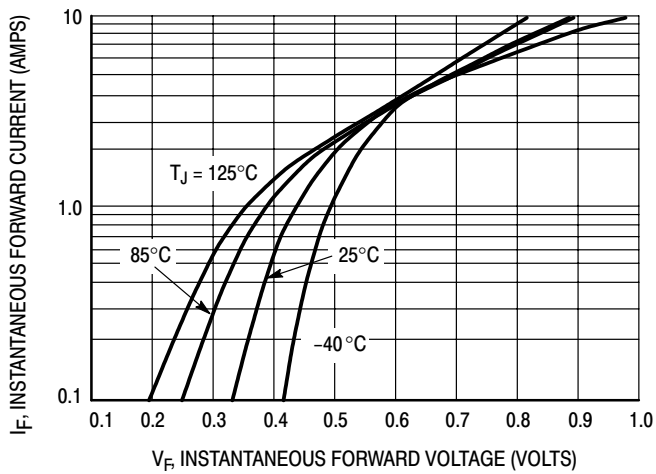


Figure 14. Typical Forward Voltage

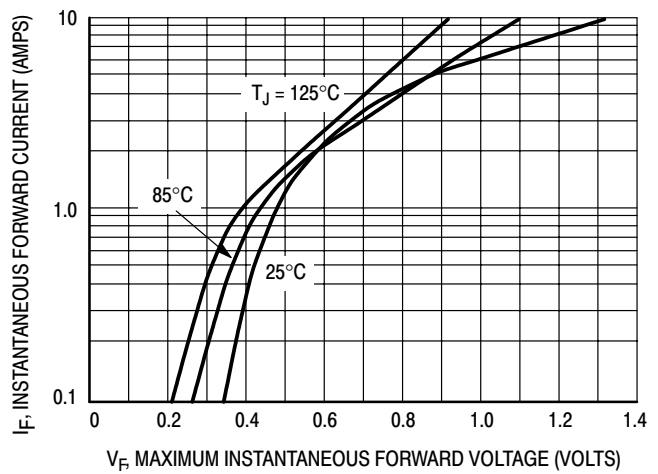


Figure 15. Maximum Forward Voltage

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

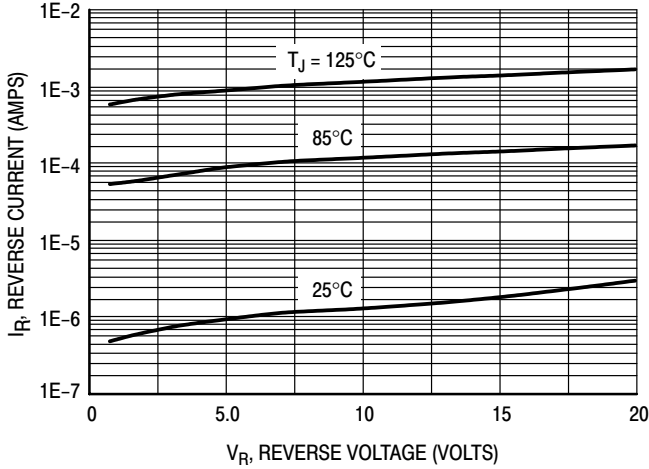


Figure 16. Typical Reverse Current

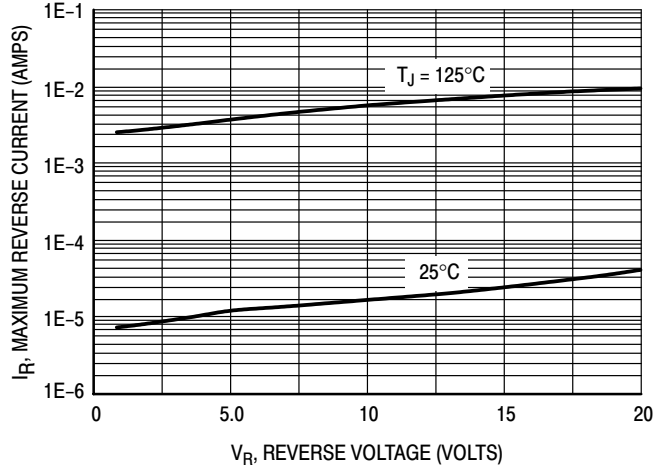


Figure 17. Maximum Reverse Current

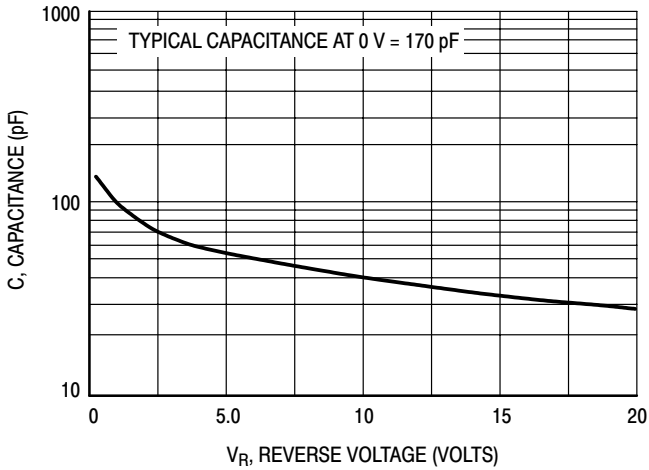


Figure 18. Typical Capacitance

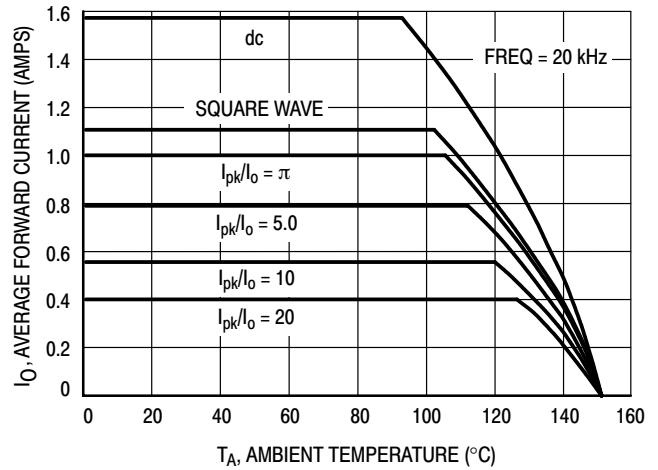


Figure 19. Current Derating

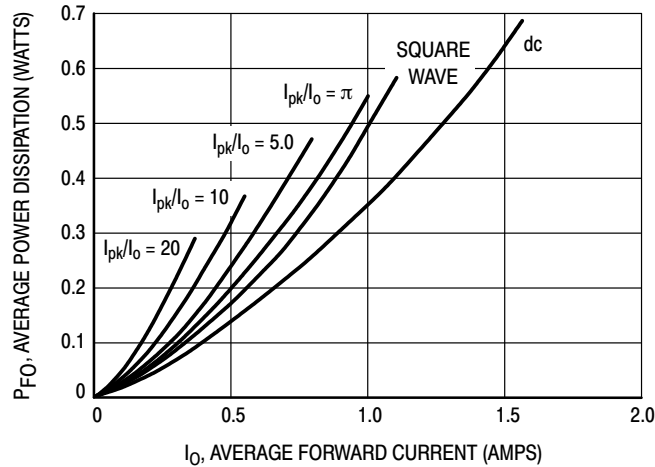
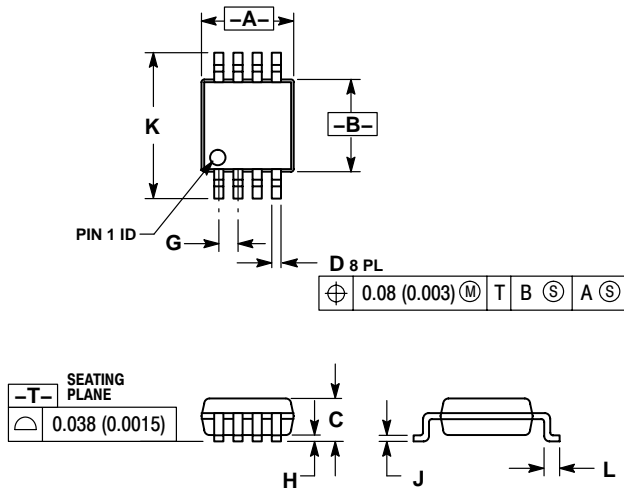


Figure 20. Forward Power Dissipation

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PACKAGE DIMENSIONS

Micro8
CASE 846A-02
ISSUE F

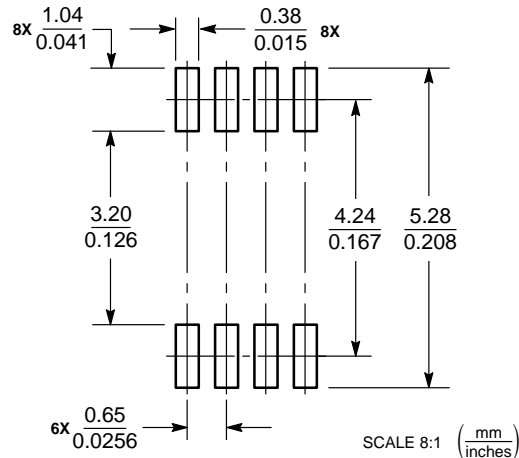


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. 846A-01 OBSOLETE, NEW STANDARD 846A-02.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.90	3.10	0.114	0.122
B	2.90	3.10	0.114	0.122
C	---	1.10	---	0.043
D	0.25	0.40	0.010	0.016
G	0.65 BSC		0.026 BSC	
H	0.05	0.15	0.002	0.006
J	0.13	0.23	0.005	0.009
K	4.75	5.05	0.187	0.199
L	0.40	0.70	0.016	0.028

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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